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Kind regards,

Team Nexperia

BUK7108-40AIE

N-channel TrenchPLUS standard level FET

Rev. 03 — 19 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS current sensing and diodes for ElectroStatic Discharge (ESD) protection. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Electrostatically robust due to integrated protection diodes
- Low conduction losses due to low on-state resistance
- Q101 compliant

- Reduced component count due to integrated current sensor
- Suitable for standard level gate drive sources

1.3 Applications

Electrical Power Assisted Steering (EPAS) Variable Valve Timing for engines

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	-	40	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 2</u> ; see <u>Figure 3</u> ;	[1]	-	-	117	Α
Static ch	aracteristics						
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 7}}{\text{Figure 8}};$ see Figure 8		-	6	8	mΩ
I_D/I_{sense}	ratio of drain current to sense current	$T_j > -55 ^{\circ}\text{C}; T_j < 175 ^{\circ}\text{C};$ $V_{GS} > 10 ^{\circ}\text{V}$		450	500	550	

[1] Current is limited by power dissipation chip rating.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		ď
2	ISENSE	sense current	mb	
3	D	drain		
4	KS	Kelvin source		
5	S	source	()()3()()	⁹ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
mb	D	mounting base; connected to	1 2 4 5	
		drain	SOT426 (D2PAK)	¦ s MBL368

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK7108-40AIE	D2PAK	plastic single-ended surface-mounted package (D2PAK); 5 leads (one lead cropped)	SOT426

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	40	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	40	V
V_{GS}	gate-source voltage			-20	20	V
I _D	drain current	$T_{mb} = 25 ^{\circ}\text{C}$; $V_{GS} = 10 \text{V}$; see <u>Figure 2</u> ;	[1]	-	117	Α
		see <u>Figure 3</u> ;	[2]	-	75	Α
		T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 2</u> ;	[2]	-	75	Α
I_{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \mu s$; pulsed; see <u>Figure 3</u>		-	468	Α
P_{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	221	W
$I_{GS(CL)}$	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5 \text{ ms}$; $\delta = 0.01$		-	50	mA
T_{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dr	ain diode					
Is	source current	$T_{mb} = 25 ^{\circ}C;$	[1]	-	117	Α
			[2]	-	75	Α
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	468	Α
Avalanche	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 75 A; $V_{sup} \le$ 40 V; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	0.63	J
Electrosta	tic discharge					
V _{esd}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ		-	6	kV

^[1] Current is limited by power dissipation chip rating.

^[2] Continuous current is limited by package.

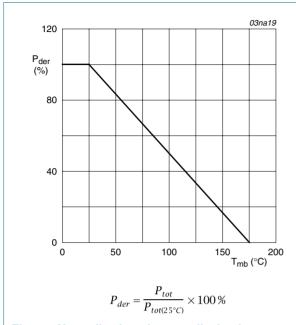


Fig 1. Normalized total power dissipation as a function of mounting base temperature

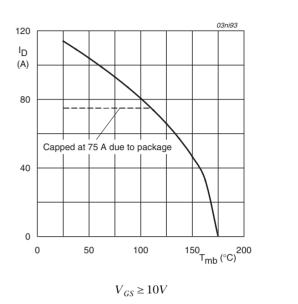


Fig 2. Normalized continuous drain current as a function of mounting base temperature

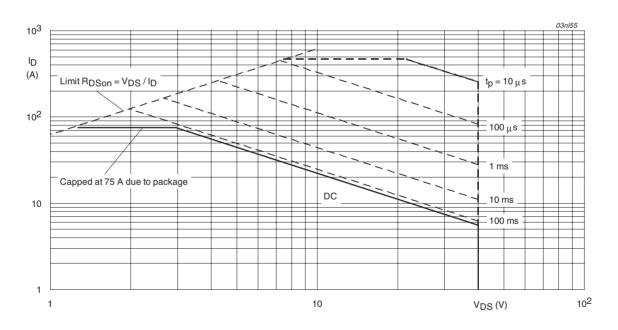


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 $T_{mb} = 25$ °C; I_{DM} is single pulse

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	50	-	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.68	K/W

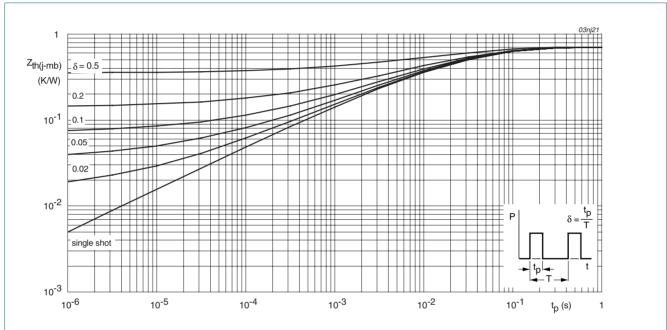


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	acteristics					
$V_{(BR)DSS}$	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	40	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	36	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see Figure 9	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 9	1	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = -55$ °C; see Figure 9	-	-	4.4	V
DSS	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.1	10	μΑ
		$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	250	μΑ
V _{(BR)GSS}	gate-source breakdown voltage	$I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
		$I_G = -1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
I _{GSS} gate leakage cui	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	22	300	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$	-	22	300	nA
		V _{DS} = 0 V; V _{GS} = 10 V; T _j = 175 °C	-	-	10	μΑ
		V _{DS} = 0 V; V _{GS} = -10 V; T _j = 175 °C	-	-	10	μΑ
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 25 \text{ °C};$ see Figure 7; see Figure 8	-	6	8	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 7; see Figure 8	-	-	15.2	mΩ
R _(D-ISENSE)	drain-ISENSE on-state	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ mA}; T_j = 25 \text{ °C}$	1.59	1.87	2.2	Ω
on	resistance	V _{GS} = 10 V; I _D = 10 mA; T _j = 175 °C	3.02	3.55	4.18	Ω
I _D /I _{sense}	ratio of drain current to sense current	$V_{GS} > 10 \text{ V; } T_j > -55 \text{ °C; } T_j < 175 \text{ °C}$	450	500	550	
Dynamic c	haracteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$	-	78	84	nC
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 14</u>	-	14	16	nC
Q_{GD}	gate-drain charge		-	34	36	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	2670	3140	pF
Coss	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	900	1053	pF
O _{rss}	reverse transfer capacitance		-	560	653	pF
d(on)	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V};$	-	19	-	ns
r	rise time	$R_{G(ext)}$ 10 Ω; T_j = 25 °C	-	76	-	ns
d(off)	turn-off delay time		-	121	-	ns
t _f	fall time		-	122	-	ns

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
L_D	internal drain inductance	from upper edge of drain mounting base to centre of die; $T_j = 25 ^{\circ}\text{C}$	-	2.5	-	nH
L _S	internal source inductance	from source lead to source bond pad; $T_j = 25 ^{\circ}\text{C}$; lead length 6 mm	-	7.5	-	nH
Source-dr	ain diode					
V_{SD}	source-drain voltage	$I_S = 40 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 17	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = -10 \text{ V};$	-	55	-	ns
Q_r	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	30	-	nC

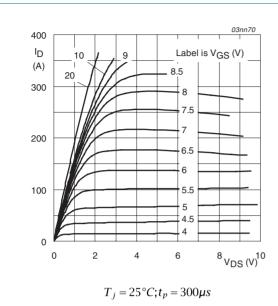
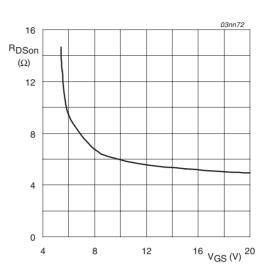


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_i = 25^{\circ}C; I_D = 50A$

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values

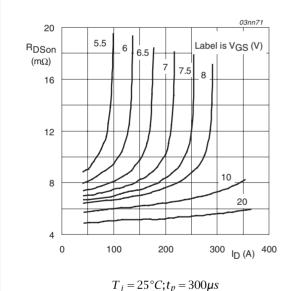
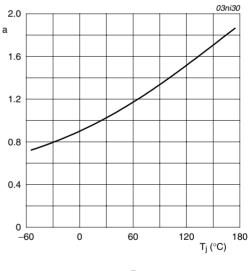
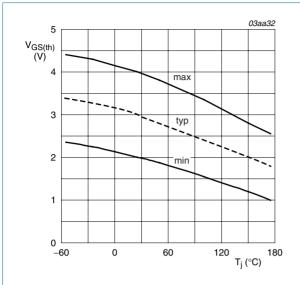


Fig 7. Drain-source on-state resistance as a function of drain current; typical values



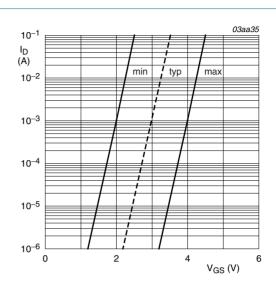
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



 $I_D = 1 \, mA; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



$$T_{j} = 25 \,^{\circ}C; V_{DS} = 5V$$

Fig 10. Sub-threshold drain current as a function of gate-source voltage

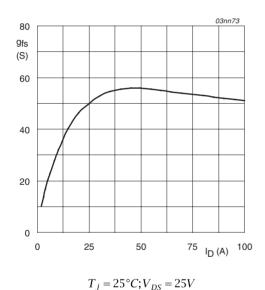
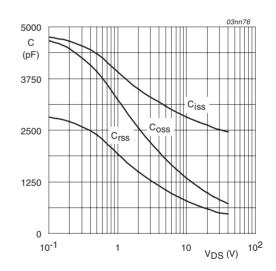


Fig 11. Forward transconductance as a function of drain current; typical values



 $V_{GS} = 0V; f = 1MHz$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

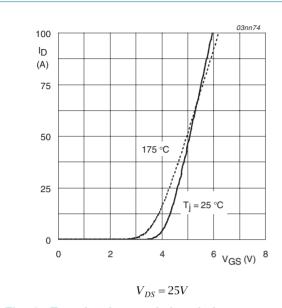


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values

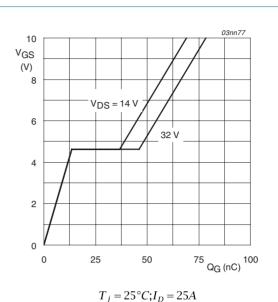


Fig 14. Gate-source voltage as a function of charge; typical values

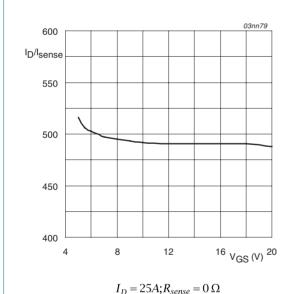


Fig 15. Drain-sense current ratio as a function of gate-source voltage; typical values

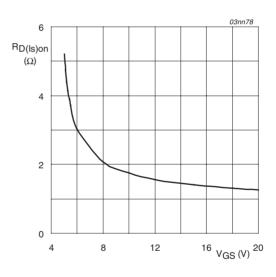
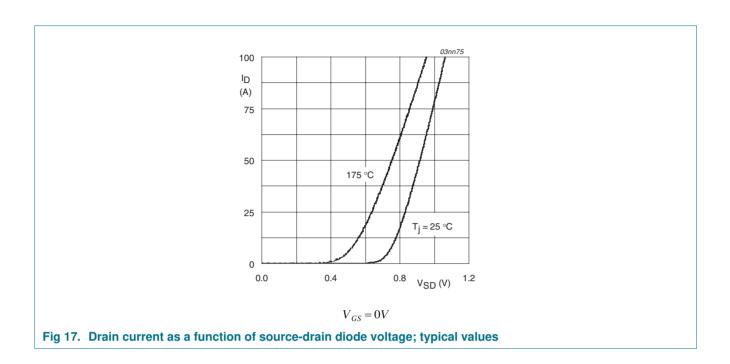


Fig 16. Drain-sense current on-state resistance as a function of gate-source voltage; typical values

 $I_{sense} = 25mA$



7. Package outline

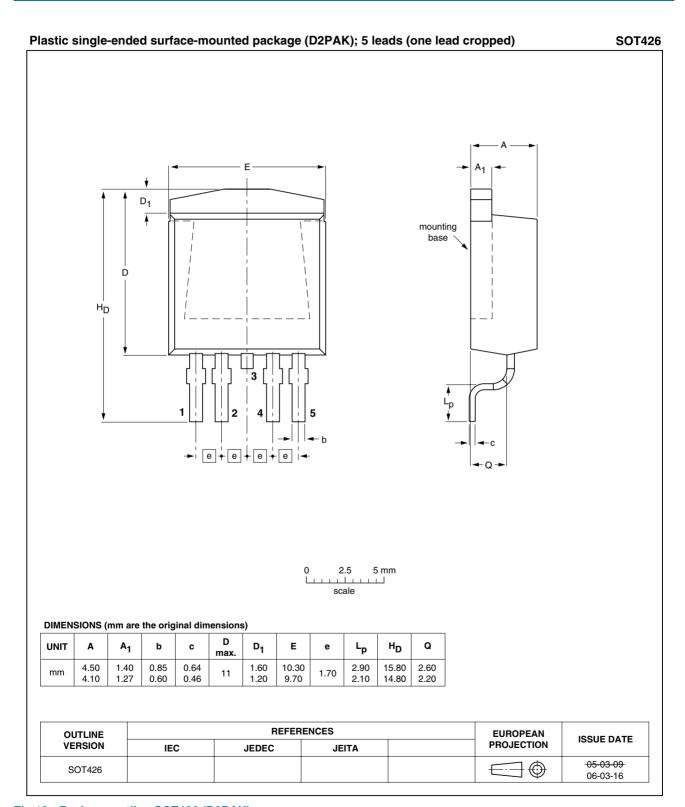


Fig 18. Package outline SOT426 (D2PAK)

8. Revision history

Table 7. Revision history

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Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7108-40AIE_3	20090219	Product data sheet	-	BUK71_7908_40AIE-02
 Modifications: The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Legal texts have been adapted to the new company name where appropriate. Type number BUK7108-40AIE separated from data sheet BUK71_7908_40AIE-02 				here appropriate.
BUK71_7908_40AIE-02 (9397 750 12086)	20031024	Product data sheet	-	BUK71_7908_40AIE-01
BUK71_7908_40AIE-01 (9397 750 11695)	20030819	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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BUK7108-40AIE

N-channel TrenchPLUS standard level FET

11. Contents

1	Product profile
1.1	General description1
1.2	Features and benefits
1.3	Applications1
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values3
5	Thermal characteristics5
6	Characteristics6
7	Package outline
8	Revision history13
9	Legal information14
9.1	Data sheet status
9.2	Definitions14
9.3	Disclaimers
9.4	Trademarks14
10	Contact information14

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